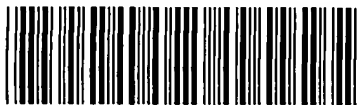


Search Notes

Application/Control No.

10/623,940

Examiner

Nhan T. Tran

Applicant(s)/Patent under
Reexamination

NAKAJIMA ET AL.

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner
348	235	12/15/2006	NT
348	365	6/14/2007	NT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	12/15/2006	NT
348/222.1, 234 (text search - see search history printout)	12/15/2006	NT
348/254 (text search - see search history printout)	6/14/2007	NT
Text search all class 348	6/14/2007	NT
Inventorship search - see search history printout	6/14/2007	NT